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Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,461	HUANG, LI-SHIN
Examiner	Art Unit
Kevin M. Nguyen	2629

SEÀRCHED				
Class	Subclass	Date	Examiner	
345	89,690	11/7/2006	KMN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			1777	

SEARCH I (INCLUDING SEAR)
		DATE	EXMR
East notes searched		11/7/2006	KMN
Inventor's name searched		11/7/2006	KMN
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